

# **Device Modeling Report**

COMPONENTS:  
DIODE/ SCHOTTKY RECTIFIER / STANDARD  
PART NUMBER: XBS013S15R-G  
MANUFACTURER: TOREX SEMICONDUCTOR

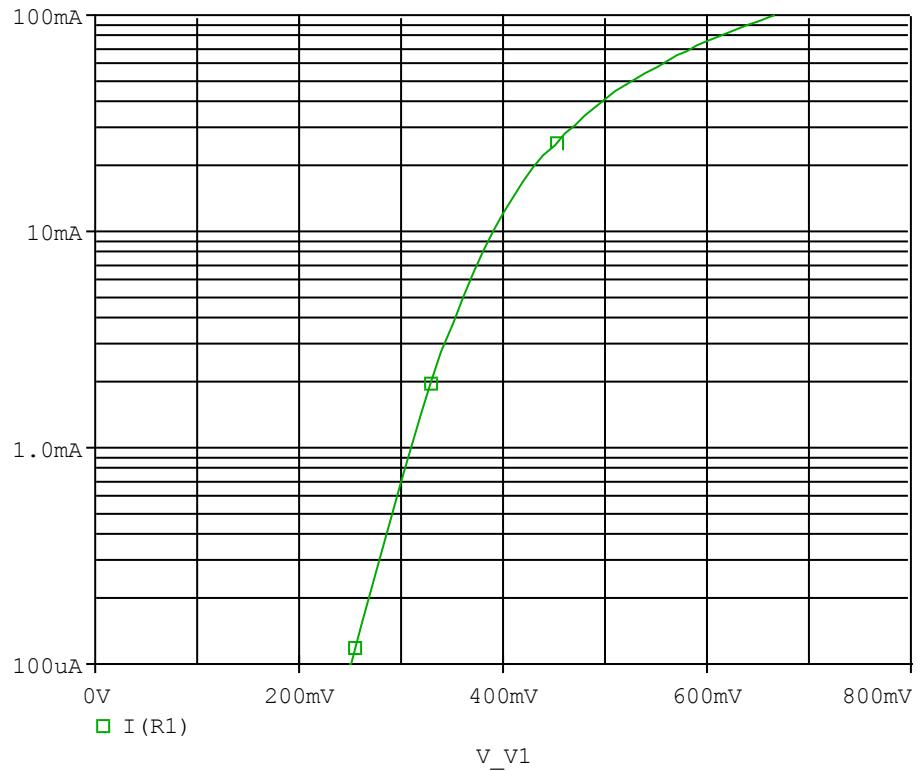


**Bee Technologies Inc.**

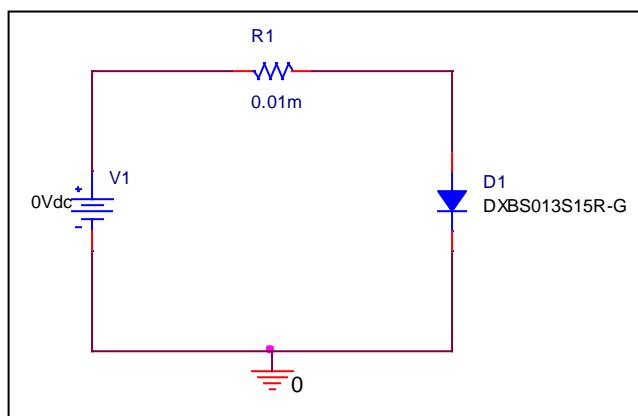
PSpice model parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time
EG	Energy-band Gap

## Forward Current Characteristic

Circuit Simulation Result

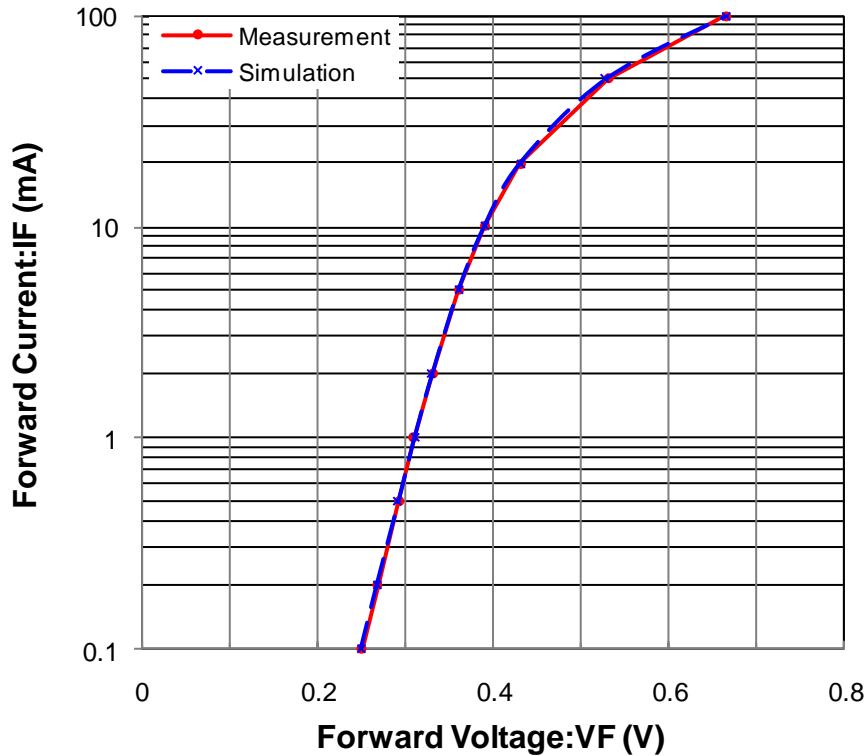


Evaluation Circuit



## Comparison Graph

Circuit Simulation Result

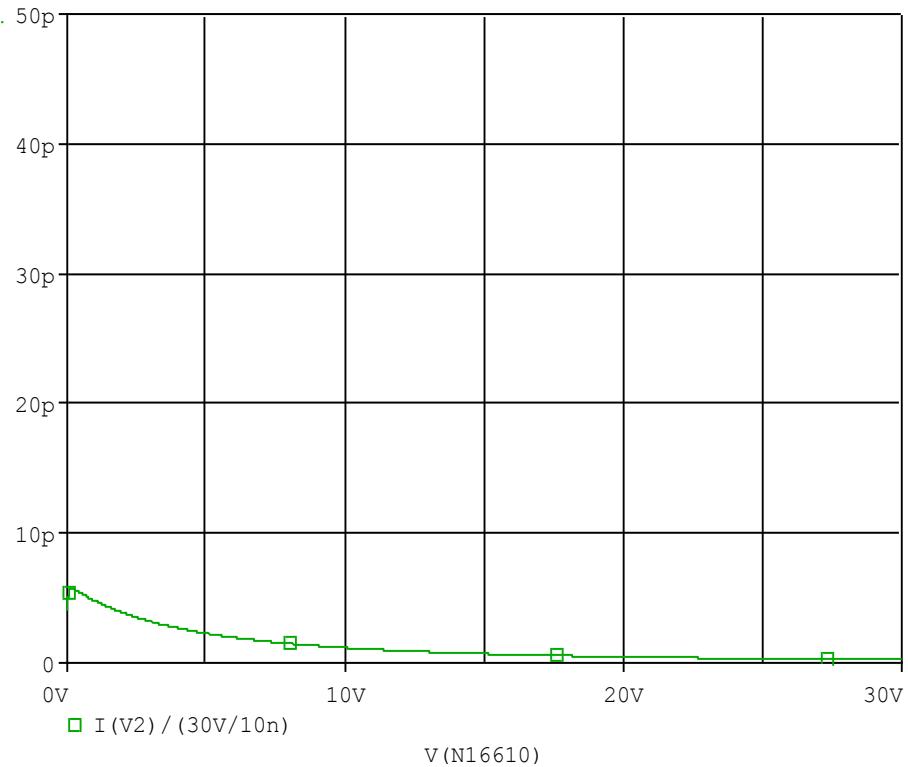


Simulation Result

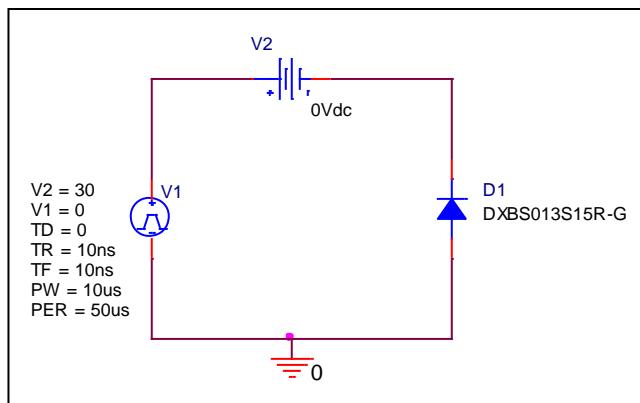
$I_F$ (mA)	$V_F$ (V)		%Error
	Measurement	Simulation	
0.1	0.250	0.248	-0.81
0.2	0.268	0.266	-0.82
0.5	0.292	0.291	-0.44
1	0.309	0.310	0.31
2	0.330	0.330	0.07
5	0.360	0.361	0.29
10	0.390	0.391	0.24
20	0.430	0.433	0.64
50	0.530	0.528	-0.37
100	0.665	0.665	0.04

## Capacitance Characteristic

### Circuit Simulation Result

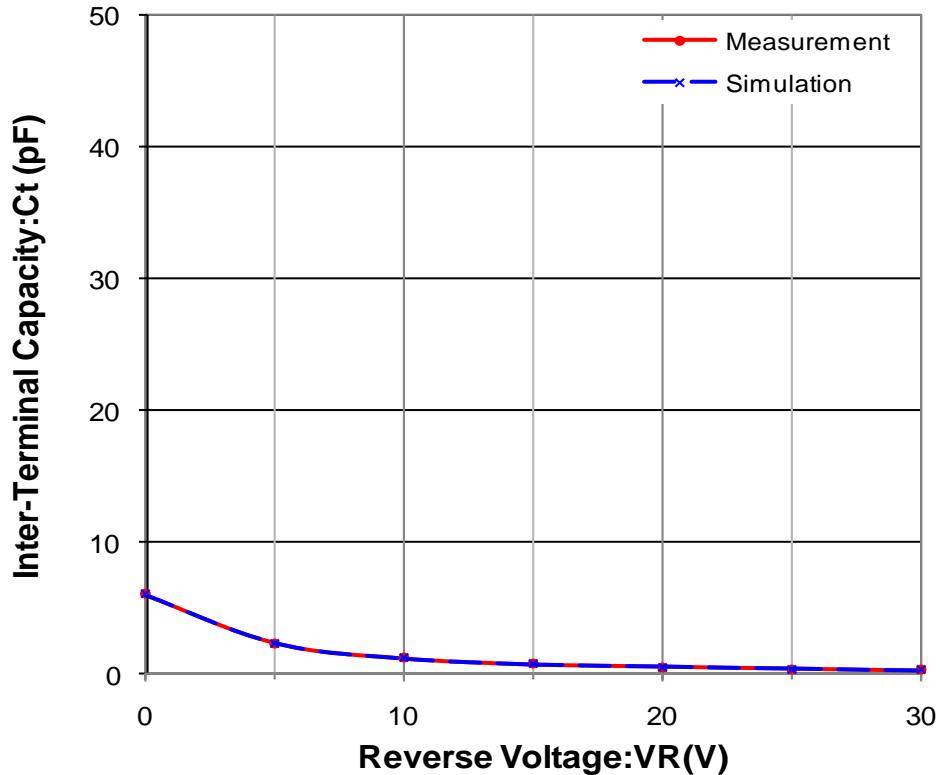


### Evaluation Circuit



## Comparison Graph

Circuit Simulation Result

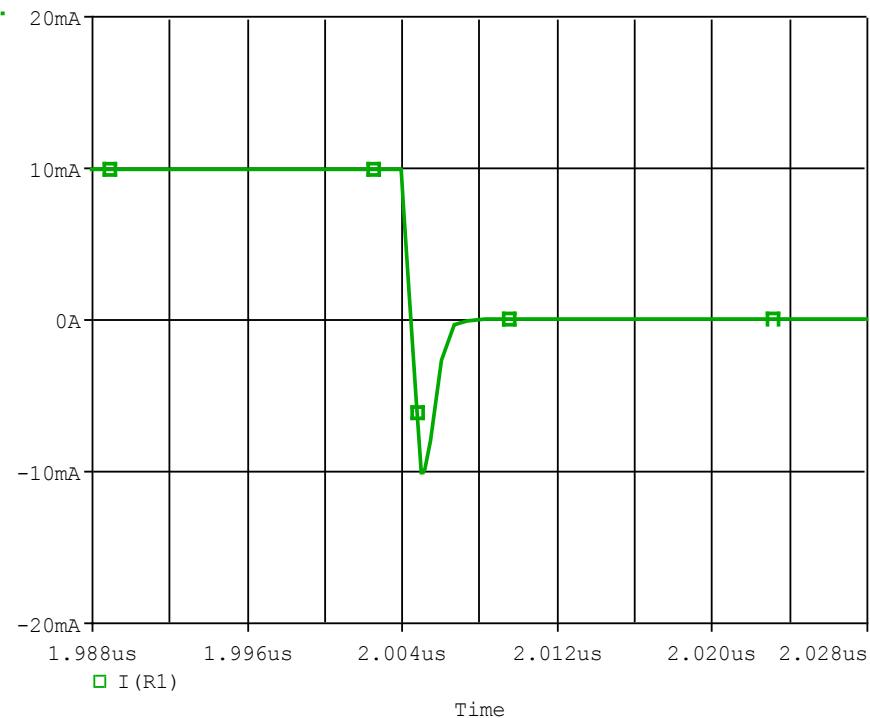


Simulation Result

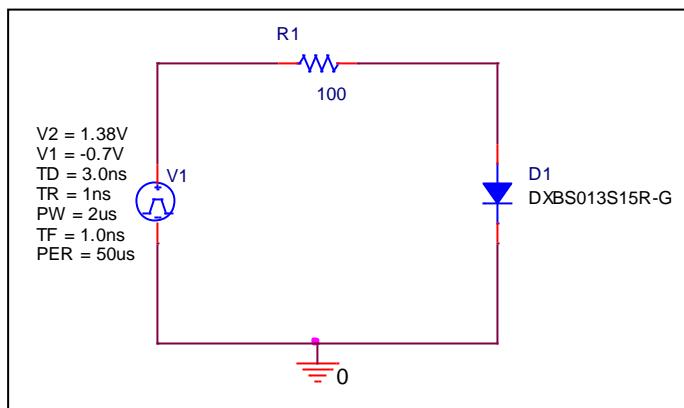
$V_R$ (V)	Ct (pF)		%Error
	Measurement	Simulation	
0	6.000	6.000	0.00
5	2.280	2.288	0.34
10	1.170	1.174	0.35
15	0.700	0.706	0.80
20	0.464	0.469	0.99
25	0.335	0.332	-0.91
30	0.258	0.247	-4.32

## Reverse Recovery Characteristic

### Circuit Simulation Result



### Evaluation Circuit



### Compare Measurement vs. Simulation

Parameter	Unit	Measurement	Simulation	%Error
trr	ns	2.000	1.959	-2.05